
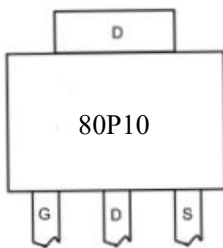

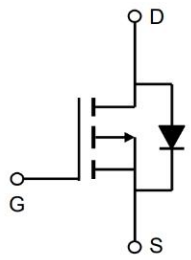




Features <ul style="list-style-type: none"> ➤ Split Gate Trench MOSFET technology ➤ Excellent package for heat dissipation ➤ High density cell design for low $R_{DS(ON)}$ 	<i>Bvdss</i>	<i>Rdson</i>	<i>ID</i>
	-100V	22mΩ	-80A
	Application <ul style="list-style-type: none"> ➤ DC-DC Converters ➤ Synchronous-rectification applications ➤ Power management functions 		
Package			
			
Marking and pin assignment	TO247 top view	Schematic diagram	

Package Marking and Ordering Information

Device Marking	Device	Device Package	Quantity
80P10	S80P10H	TO247	50

Absolute Maximum Ratings ($T_C=25^{\circ}\text{C}$ unless otherwise specified)

Parameter	Symbol	Value	Unit	
Drain-Source Voltage	V_{DS}	-100	V	
Gate-Source Voltage	V_{GS}	± 20	V	
Continuous Drain Current	$T_C=25^{\circ}\text{C}$	I_D	-80	A
	$T_C=100^{\circ}\text{C}$	I_D	-41	A
Pulsed Drain Current ¹	I_{DM}	-260	A	
Single Pulse Avalanche Energy	EAS	-	mJ	
Power Dissipation	$T_C=25^{\circ}\text{C}$	P_D	250	W
Operating junction and storage temperature	T_J, T_{STG}	150, -55 ~ 150	$^{\circ}\text{C}$	
Maximum Temperature for Soldering	T_L	260	$^{\circ}\text{C}$	



Thermal Resistance Ratings

Parameter	Symbol	Value	Unit
Thermal Resistance Junction-Case	$R_{\theta JC}$	0.5	$^{\circ}C/W$
Thermal Resistance, Junction -to-Ambient	$R_{\theta JA}$	62	$^{\circ}C/W$

Ordering Information

Ordering Number	Package	Pin Assignment			Packing
Halogen Free		G	D	S	
HLS80P10H	TO247	1	2	3	Tube

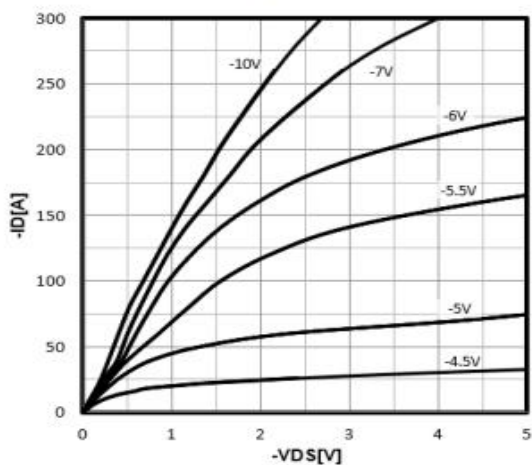
Electrical Characteristics ($T_j=25^{\circ}C$ unless otherwise noted)

Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Unit
Drain-Source Breakdown Voltage	$V_{(BR)DSS}$	$V_{GS}=0V, I_D=-250\mu A$	-100	-	-	V
Drain to Source Leakage Current	I_{DSS}	$V_{DS}=-100V, V_{GS}=0V$	-	-	1	μA
Gate to Source Forward Leakage	I_{GSS}	$V_{GS}=\pm 20V$	-	-	± 100	nA
Gate-Threshold Voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}, I_D=-250\mu A$	-2	-3	-4	V
Drain-Source On-Resistance	$R_{DS(on)}$	$V_{GS}=-10V, I_D=-15A$	-	22	25	m Ω
Input Capacitance	C_{iss}	$V_{DS}=-50V, V_{GS}=0V,$ $f=1MHz$	-	4200	-	pF
Output Capacitance	C_{oss}		-	536	-	
Reverse Transfer Capacitance	C_{rss}		-	52	-	
Total Gate Charge	Q_g	$V_{GS}=-10V, V_{DS}=-50V, I_D=-15A$	-	76	-	nC
Gate-Source Charge	Q_{gs}		-	13	-	
Gate-Drain Charge	Q_{gd}		-	12.4	-	
Turn-On Delay Time	$t_{d(on)}$	$V_{GS}=-10V, V_{DS}=-50V,$ $R_G=3\Omega, I_D=-15A, R_L=0.75\Omega$	-	13	-	ns
Rise Time	t_r		-	51	-	
Turn-Off Delay Time	$t_{d(off)}$		-	177	-	
Fall Time	t_f		-	82	-	
Diode Forward Current	I_S	$T_C=25^{\circ}C$	-	-	-80	A
Diode Forward Voltage	V_{SD}	$I_S=-15A, V_{GS}=0V$	-	-	-1.2	V
Reverse Recovery time	T_{rr}	$I_S=-15A, V_{DD}=-50V$ $di/dt=100A/\mu s$	-	110	-	ns
Reverse Recovery Charge	Q_{rr}		-	590	-	nC

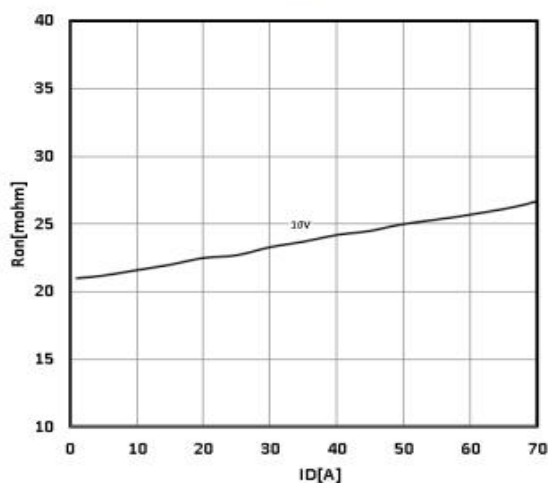


Typical Performance Characteristics

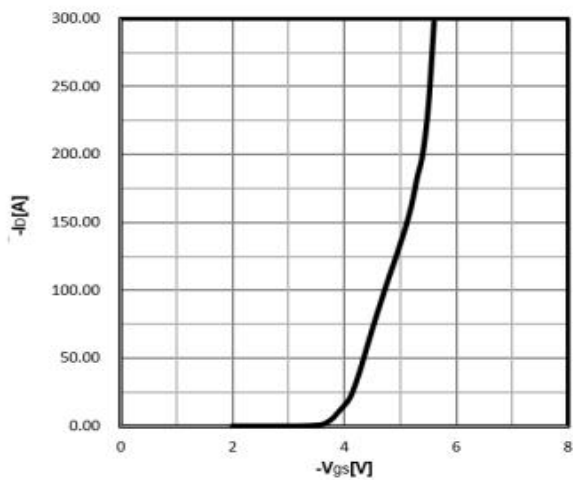
Typ. output characteristics
 $I_D=f(V_{DS})$



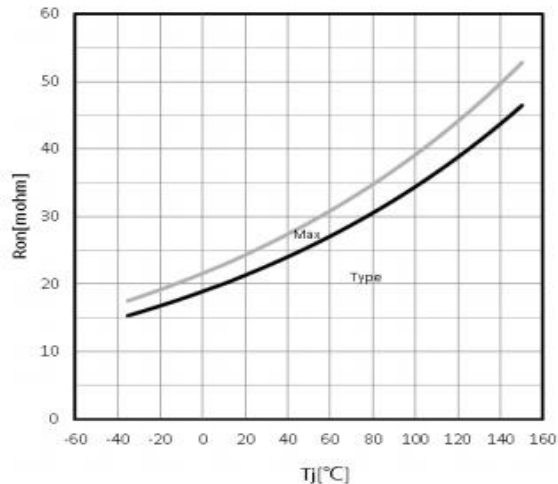
Typ. drain-source on resistance
 $R_{DS(on)}=f(I_D)$



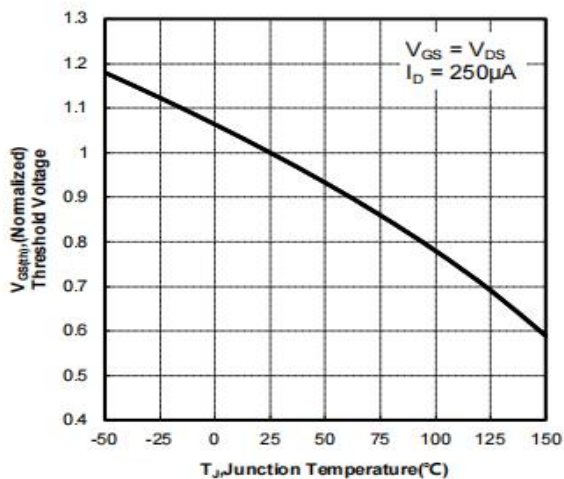
Typ. transfer characteristics
 $I_D=f(V_{GS})$



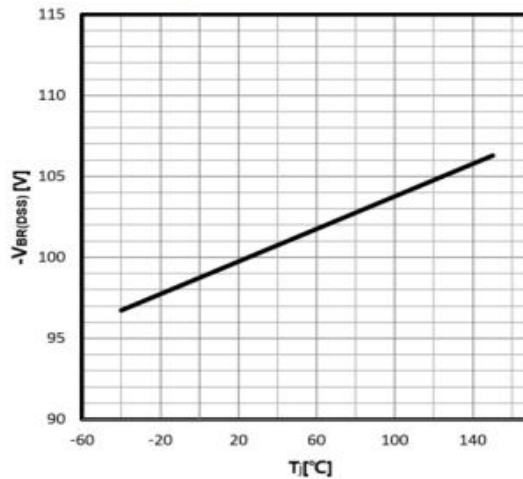
Drain-source on-state resistance
 $R_{DS(on)}=f(T_j); I_D=-15A; V_{GS}=-10V$



Gate Threshold Voltage
 $-V_{TH}=f(T_j); I_D=-250\mu A$

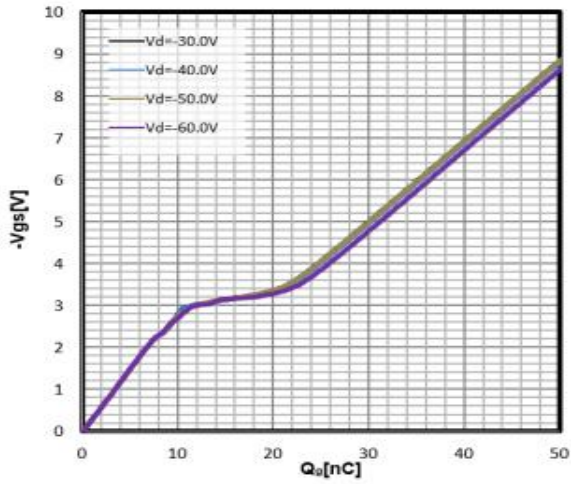


Drain-source breakdown voltage
 $V_{BR(DSS)}=f(T_j); I_D=-250\mu A$

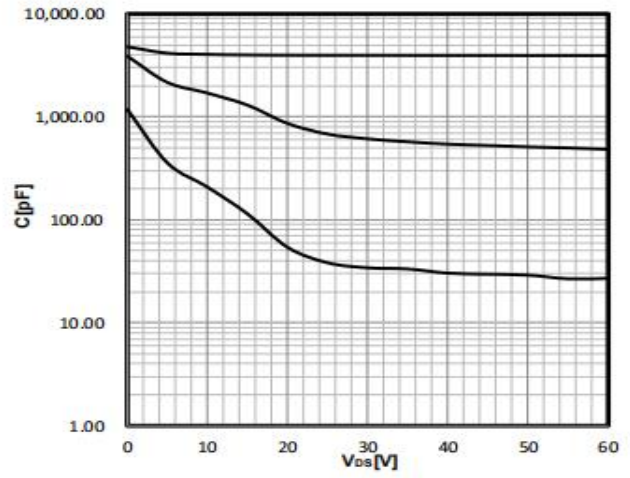




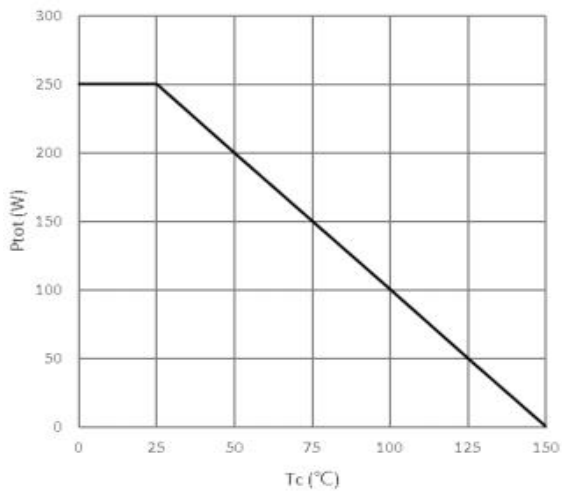
Typ. gate charge
 $V_{GS}=f(Q_{gate}); I_D=-15A$



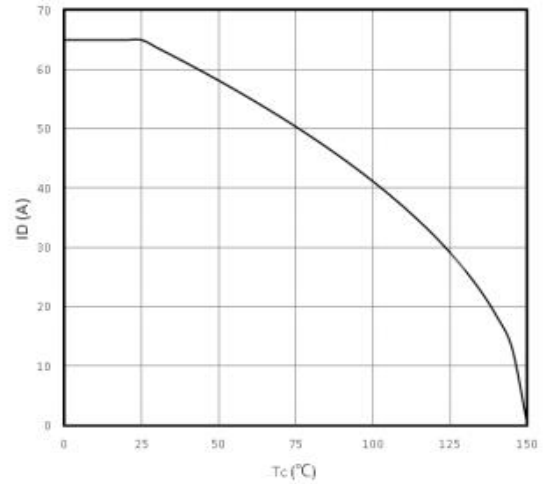
Typ. capacitances



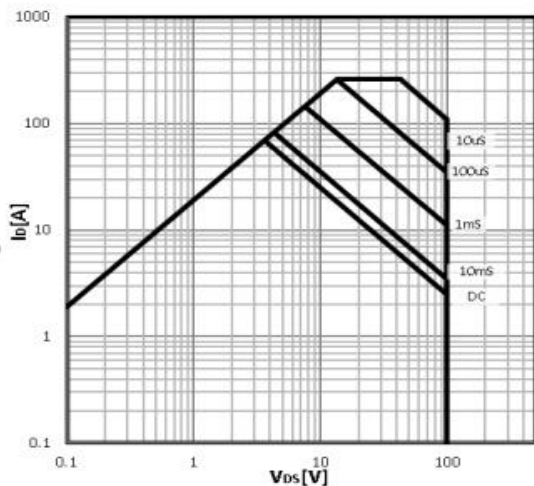
Power Dissipation
 $P_{tot}=f(T_C)$



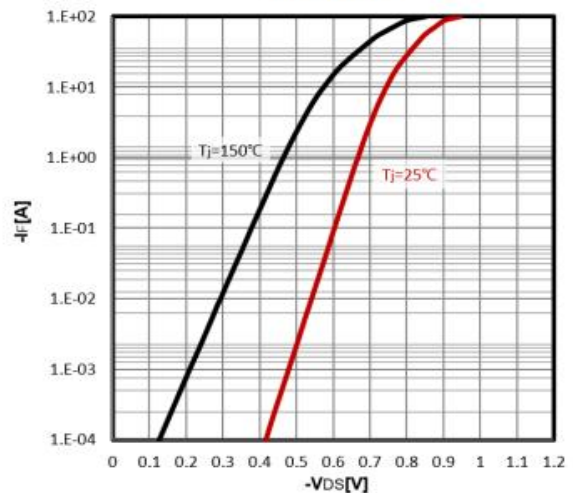
Maximum Drain Current
 $-I_D=f(T_C)$



Safe operating area
 $-I_D=f(-V_{DS})$



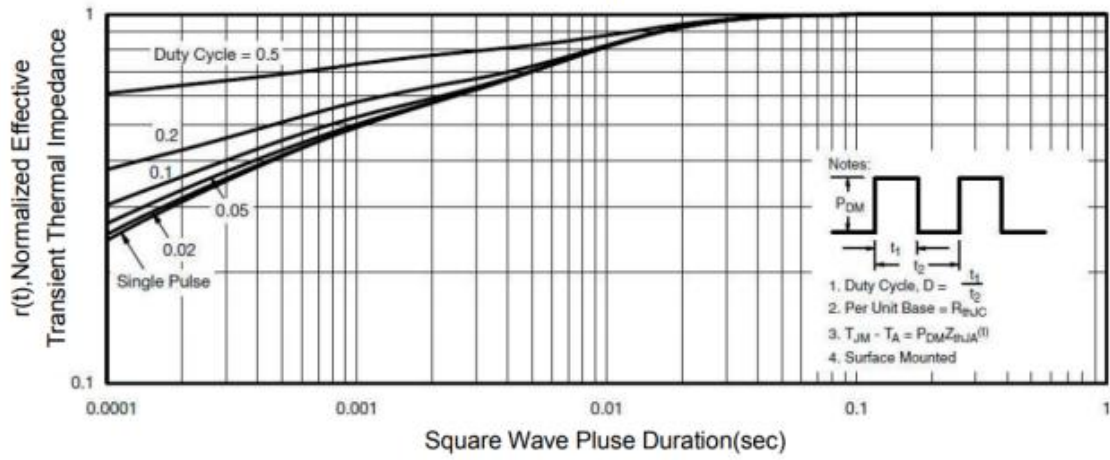
Body Diode Forward Voltage Variation
 $-I_F=f(-V_{DS})$





Max. transient thermal impedance

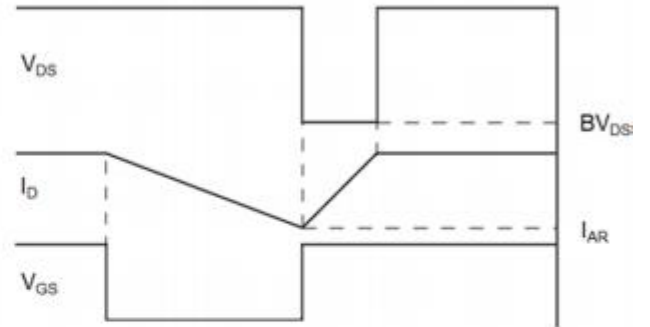
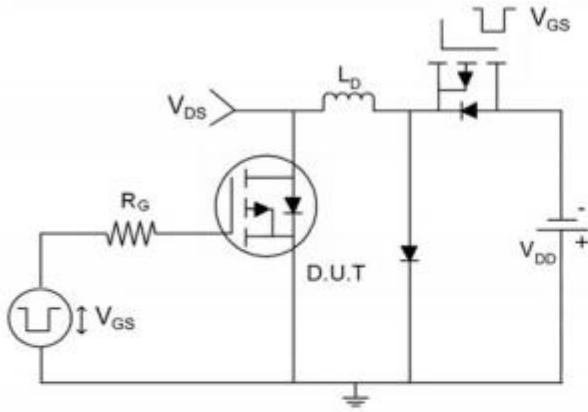
$$Z_{thJC} = f(t_p)$$



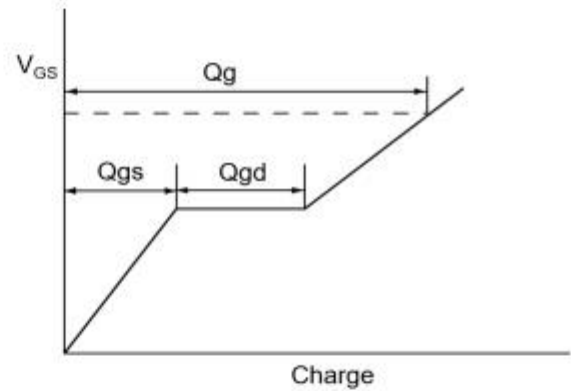
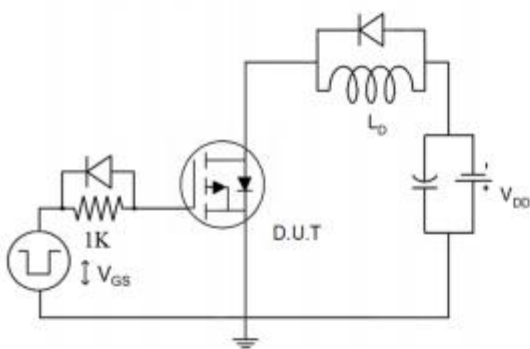


Test Circuit and Waveform

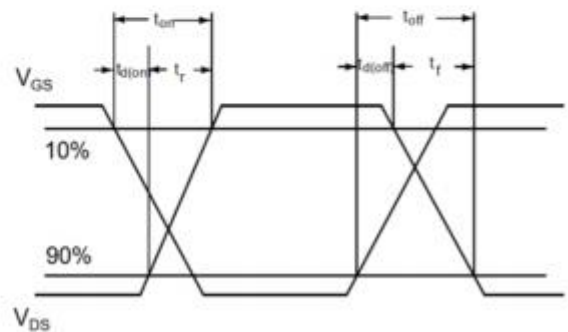
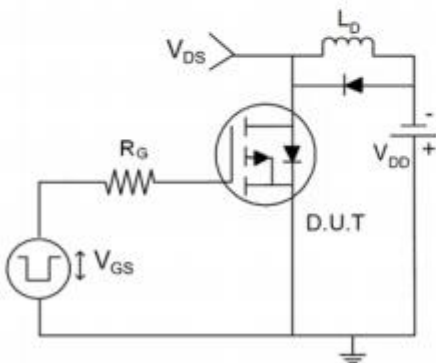
1) E_{AS} Test Circuits



2) Gate Charge Test Circuit



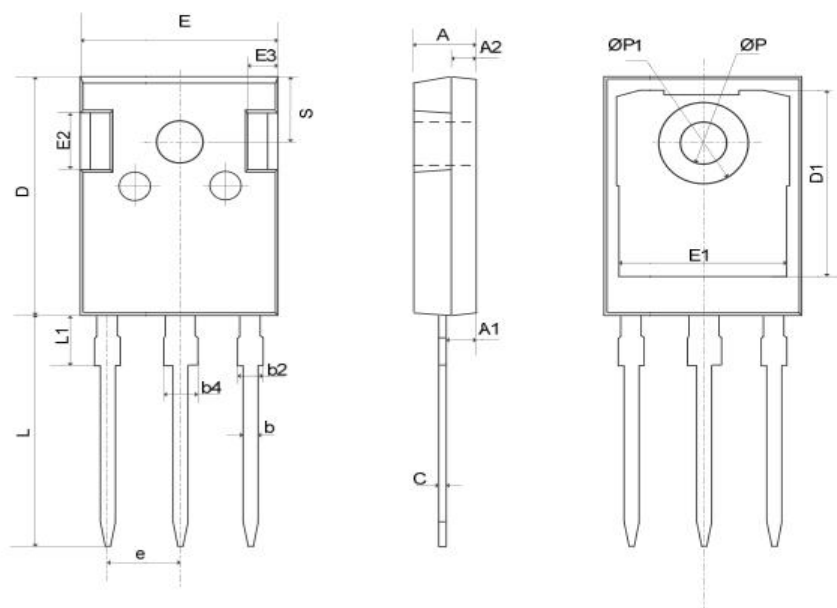
3) Switch Time Test Circuit





Package Dimensions TO247

COMMON DIMENSIONS



SYMBOL	MM	
	MIN	MAX
A	4.80	5.20
A1	2.21	2.61
A2	1.85	2.15
b	1.11	1.36
b2	1.91	2.21
b4	2.91	3.21
c	0.51	0.75
D	20.70	21.30
D1	16.25	16.85
E	15.50	16.10
E1	13.00	13.60
E2	4.80	5.20
E3	2.30	2.70
e	5.44BSC	
L	19.62	20.22
L1	—	4.30
ØP	3.40	3.80
ØP1	—	7.30
S	6.15BSC	



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